4ITM06-C

LIGO-T990156-00-D

BLANK

LIGO-M960129-C-P

	GO DETECTOR ning Inspection Character Core Optics Blank	eck-off Sheet			Page 1 of Z
The purpose of this sheet is to verify material purpose of LIGO Detector optics. This sheet Complete a check-off sheet for each optic blank	et is to be included	in the LIGO Q	-		
C. LIGO Contract No.: PC 208421 E. Core optic Material: (BS / FM / ITM) E G. LIGO Drawing No.: D960794 - A	ETM / RM) F.	Glass Mfg. Par	rt No.: _ Boule l	50764 No.: <u>Melt</u> 1	MF.F 8496
K M Attach a copy of the glass manufacture.	en against LIGO C ification Verification inspection report r's Certification to	on sheet. Check-off sheet.			
Attach the glass manufacturer's birefringence of M Visually inspect for shipping container	nd inclusion r	naps not pi	resent	5	-
N Visually inspect the blanks for damage, describe damage/defects on attached she	for chips on surfaceet.	ces and edges, o	r for oth		
O Verify core optic blank physical dimens		LIGO drawing			
Inspection of material diameter.	Diameter	10.10	in	256.6	mm
Inspection of material thickness.	Thickness	4.27	in	108.8	mm
P Verify that the Registration Mark is pre Component Specification. No regi	sent (with arrow po stration ma	ointing to the fir	st surfac Ł	ce) as required	by LIGO
Q Verify receipt of 25mm X 25mm cylind and visually inspect for damage. Descri	ibe damage on the	attached sheet.	shipp	Component S	Specification ep e rately
R Sign and date original packing slip (ship	per) and distribute	per paragraph	3. R .		
Inspect By:		Date Insp	ected:	10-08-9)7
Reviewed and/or accepted by:					
Cognizant Engineer:		Date:			
LIGO QA Officer or Designee:		Date:			
FM300	Figure 1				

LIGO DETECTOR OPTICS Incoming Inspection Check-off Sheet

Core Optics Blank Material

COMMENTS/DISCREPANCIES: (Disposition damage/discrepancies per LIGO Quality Assurance Plan (LIGO M960076-00-P) paragraphs 5.12 and 5.12.1.) No data disk (FTP not referenced)
Minimal chamfer. No defect map. No registration marks
No interferograms or homogeneity maps. No birefringence
map. No inclusion sketch. No absorption certification.
Striae not reported. No OH-content reported.
Witness sample shipped separately.
SKETCHES:
DISPOSITIONS: Received new inspection report 12-30-97
Received defect, inclusion, and striae sketch.
Received residual strain report.
Received OH-content report and graph.
Received interferograms and homogeneity maps.

LIGO Component Specification Verification Sheet Mirror Blanks, Input Test Mass

	Se	rial Number: TM Ø9	Specification	Reported Value	~
		Physical Dimensions	LIGO-D960794		1
		Diameter	256mm +1.0mm, -0mm	256,6 mm	V
		Thickness	108mm +1.0mm, -0mm	108.8 mm	~
		Chamfer	2.0mm Max 2pl	minimal	
		Clear Aperture	Central 235mm		
SSE		Material	Fused Silica # 73 #7980	Certification	
t M		Registration Mark	"Top" of Optic, 80mm Arrow Points to Side 1	Certification	None
Tes		Witness Sample	25mm dia. x 25mm cylindrical	shipped separately	<u></u>
=		Witness Sample Map		Map Attached	
Inp	ents	Defect Depth	< 0.5mm	Hand Sketch w/location & dim.	No
ıks,	Requirements	Homogeneity Within the Central 80mm	$\leq 5.0 \times 10^{-7} p - v$ $\lambda = 632.8 nm$	Interferogram Homogeneity Map	N.
Blar	Requ	Homogeneity Within the Central 200mm	$\leq 2.5 \times 10^{-6} \text{ p - v}$ $\lambda = 632.8 \text{nm}$	Interferogram Homogeneity Map	N.
Mirror Blanks, Input Test Mass		Homogeneity Data	ASCII Format	PC Compatable 3½ in. Disk	N.
Mir		Birefringence Within the Central 80mm	≤ 1 nm/cm	Certification, Birefringence Map	No
		Birefringence Within the Central 200mm	≤ 5 nm/cm	Certification, Birefringence Map	N _o
		Bubble & Inclusion within the clear aperture. Max. Inclusion Diameter	Total $\leq 0.03 \text{mm}^2$ Per 100cm^3 of Glass. $\leq 0.1 \text{mm}$	Hand Sketch w/location & dim.	No
		Absorption	2 ppm/cm λ= 1.06μm	Certification	No.
		Striae within the Clear Aperture	Grade A per MIL-G-174	Inspection Report	No

 $Blnk_ITM.doc$

Heraeus QUARZGLAS POL-QW

INSPECTION REPORT

Project LIGO

Customer : HERAEUS Amersil Inc. Duluth, Ga 30136-5821

Order No. : 45000023300dtd 30.09.96 as

HAI-Order No. : none

HQS-Order No. : 94908401

Item No. : 1

Quality : Fused silica Suprasil 312 S

HQS melt No. : MF.F 8496

Diameter : 256,6 mm

CA Diameter : \emptyset 200 mm = 2,33xE⁻⁶

Thickness : 108.8 mm

Edge : 0,3 - 0,5 mm

Parallelism : < 0,08 mm

Roughness : ground

R_a : 1,08 μm **R**_t : 8,86 μm

Bubble class : 0; none bubbles

Birefringence : CA Ø200 mm <= 5nm/cm

Homogeneity : see Interferogram

Striae Grade : A

Granularity : none

Remark: Test Sample (Ø25 x25 mm) with the same marking

POL - Qualitätsprüfung Optik

Date : 15.08.1997

Inspector: O.Dauth Munk

Heraeus QUARZGLAS

POL-QW

Order Nr.: 94908401 Pos.: 1

Ø 256,6 mm x 109,8 mm Quality: Suprasil 312,

Plate No.: 960045-1409 / 5014

Date: 15.08.97

inspector:

defect depth: none Bubble: none

Bubble: none Inclusion: none Striae: none

Diameter	0,03mm	0,05mm	0,08mm	0,12mm	0,2mm	0,31mm	Sum
piece							
mm²							

TBCS=

mm² /100cm³ Heraeus QUARZGLAS

POL - QW

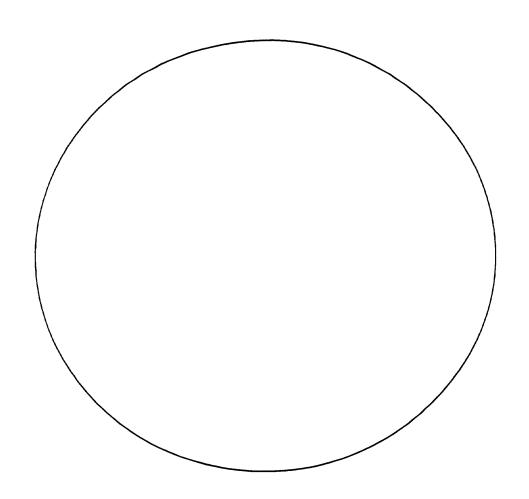
Order No.: 94908401 Pos.: 1 Ø 254,6 mm x 108,8 mm

Plate No.: 960095 - IM 09/ 5014
Residual strain- Report

Date: 15.08.97

Inspector:





Edge	Center			Pos.
20				nm
2	<1			nm/cm

10=88.6103 , 11=81.1361 at x=7225

OH-content: 153.1 ppm



MEASURE NO.

: 5014

DATE

: 02.09.1997

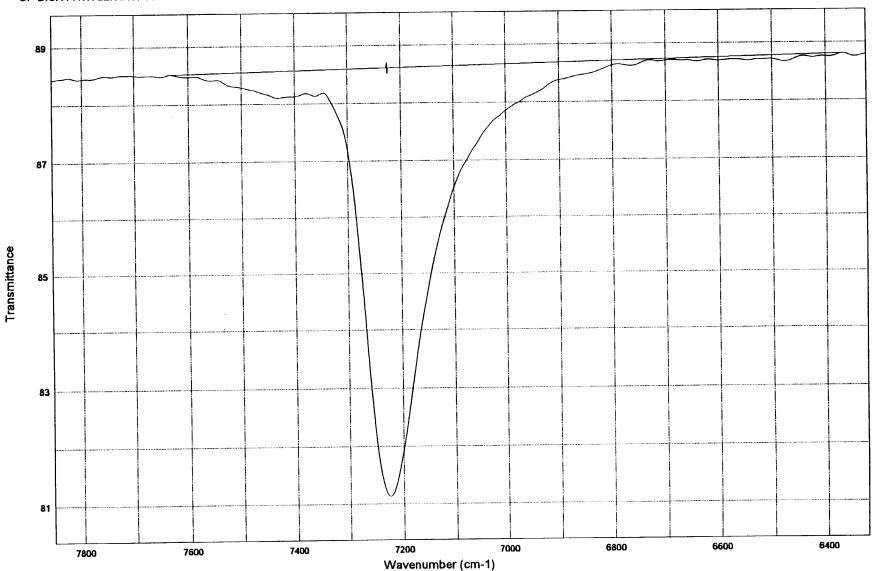
TIME: 10:32

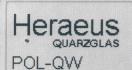
MEASURE START MEASURE END

: 10000 1/cm

: 2000 1/cm

OP-DISK-PATH LENGTH: Ko-200-PL: 4.0 cm / Order No.: 9999 9999 / Material: Su 311----OH-content: 153.1 ppm at x=7225





Meßwellenlänge 632.8 nm

Datum: 02.08.97 ID: 501400 Bediener: Rt

Nr.:

HQS-Auftr.-Nr.: 98492868

Kunde: HAI Produkt: LIGO Pos.-Nr.: 1

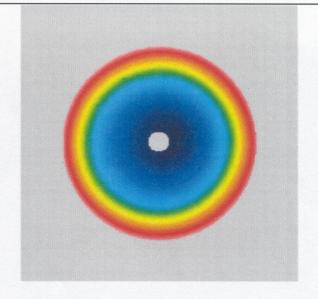
Auftrags-Nr.:

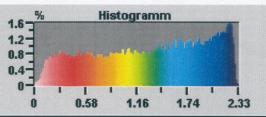
Kommentar: 960095-im ~ 09

Probendicke: 108.8 mm Probendurchm.: 280.0 mm CA-Durchm.: 200.0 mm Bilddurchm.: 200.3 mm

Mittelpunkt: (0.0mm,0.0mm)

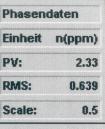
Radius: 100.1mm Punkte: 69729



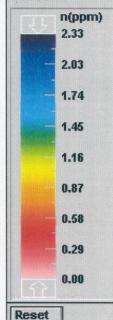


Sub. Terme	Betrag	Winkel
XTilt	0.2175	-13.6417
Fokus	-1.1056	
Astigm.	0.0445	-78.8291
Koma	0.0310	45.0542
SA3	-0.1621	

Datei: 501400.tif, 02.08.97, 08:41



Kontrast



AL - A	0.005
OberG	2.325
UnterG	0.000





Heraeus Amersil Inc 3473 Satellite Blvd. Duluth, GA 30136

Heraeus AMERSIL

Pick Ticket

Sales Order #: 5001652 Delivery #: 30035153

Terms: FOB Duluth

Customer PO # pc208421

65 + 25 + 5

78462731

SHIP TO: 5594

CALIFORNIA INST OF TECH

Attn: Gari Billingsley 391 SOUTH HOLLISTON PASADENA, CA 91125

ref quote# 9607054

Order Entered By: DANB

Salesman: 00000020 MARC SCHNEIDER

Route: UPS002 UPS Blue 2 Day PPA Actual Route: Lynden Overnight

LINE **PART** DESCRIPTION UNIT SHIP PICK ACTUAL PICK UNIT ITEM NUMBER MEAS DATE QTY PICK QTY LOCATION PRICE 50784 DISC, SUP 312, G, 256 X 108 000002 EΑ 10/07/1998 11.000 ANTOI) order from HQS \$43,910 ea. dlvry approx. 12 months.....part includes a witness aproximately 25mm diameter X 25mm thick from a nearby portion of the ingot prior to hot form flow out IMØ9

Special Packaging:	@ \$ a piece
# of Shipping Cartons:	
Total Weight of Shipment: 356	
Insurance Charge:	Freight Charge:
Picked By:	<u> </u>
Date: \$\\\ 10-1-97!	

SUBSTRATE

A. DCN: LIGO-T970039-01-D LIGO DETECT B. LIGO S/N: 4ITMØ6-C Incoming Inspection Core Optics Pol	on Check-off Sheet	Page <u>1</u> of <u>3</u>
The purpose of this sheet is to verify material physical dime facilitate material traceability of LIGO Detector optics. This traceability file. Complete a check-off sheet for each optic	s sheet is to be included i	n the LIGO Quality Assurance
C. LIGO Contract/Purchase No.: PC 167159 E. Core optic Material: BS / FM / 2ITM / (4ITM) ETM / RI	D. Substrate Polisher: M F. Date Received:	<u>CSIRO</u> 02-22-99
G Verify glass polisher's Certification with LIGO Comp Attach the completed LIGO Component Specification	onent Specification No	
H Attach a copy of the glass polisher's Certification Doo	ument and data sheet to c	heck-off sheet.
I. Verify receipt of an IBM PC compatable disc in ASCI Component Specification sheet	I format of all Surface Da	ata per the applicable LIGO
J Attach the surface maps supplied by vendor per above	Component Specification	ns to the check off sheet.
K Visually inspect for shipping container damage. If app Cognizant Engineer	olicable, describe damage	on attached sheet and notify the
L Visually inspect the polished substrate for shipping date defects. If applicable, describe damage/defects on atta		
M Verify polished substrate's physical dimensions per ap	plicable LIGO drawing.	
Inspection of material diameter. Unspection of material thickness Wedge Angle 1° 12′ Diameter Thickness		250,95 mm 100.013 mm *
N Verify that the Serial Number is present in the proper f	ormat as required by LIG	O Component Specification.
O Verify that the Registration Mark (line with arrow by LIGO Component Specification.	pointing toward surface	e #1) is present as required
P Inspect the sides and bevels with the naked eye in norn that there is no gray, scuffs or scratches per the applications.		

Q Use a dark field microscope at 5X magnification to inspect the polished optic for scratches and defects over the central 80 mm diameter per the applicable LIGO Component Specification.

LIGO DETECTOR OPTICS Incoming Inspection Check-off Sheet

Core Optics Polished Substrate

Think	paragraphs 5.12 and 5.1		1 .	
11114	1622. 0.012	mm above t	op tolerance.	
			•	
		······································		
KETCHES:				
See	drawings su	ipplied by CS	IRO for side 1	
				•
•				
SPOSITIONS:				
-				
	<u> </u>			
	· · · · · · · · · · · · · · · · · · ·		•	

Sign and date original packing slip (shipper) and distribute per paragraph 3.R.						
Inspection By:	Date Inspected: 2-22-99					
Reviewed and/or accepted by:						
Cognizant Engineer:	Date:					
LIGO QA Officer or Designee:	Date:					
FM300	Figure 1					

	Seria	Number: 4TTMØ6-C	Specification	Reported Value	~	
	-	Surface Figure Over Central 200mm dia.	Spherical, Concave			
	Surface	Radius of Curvature Tolerance	14,180m +140m, -1000m	13,630m		
SSI	Š	Astigmatism	< 13nm p-v	6.2 nm	1	
t Ma	7	Surface Figure Over Central 200mm dia.	Nominally Flat			۲,
Test	Surface	Radius of Curvature of the Wavefront	9,740m +500m, -100m	-5.03	V	5.1
put	S	Astigmatism	< 15nm p-v	4.1 nm	~	<i></i> 4.8
e, In	rors	Low Spatial Frequency Band Central 80mm	\leq 4.3 cm ⁻¹ $\sigma_{\rm rms}$ < 0.8nm	0.6nm	~	
trat	Surface Errors Surface 1	Low Spatial Frequency Band Central 200mm	\leq 4.3 cm ⁻¹ $\sigma_{\rm rms}$ \leq 1.6nm	1.3 nm	V	
Substrate, Input Test Mass	Surfa	High Spatial Frequency Band Central 80 & 200 mm	$\leq 4.3 - 7,500 \text{ cm}^{-1}$ $\sigma_{rms} < 0.2 \text{nm}$	0.19 0.20	レ	
	rors 2	Low Spatial Frequency Band Central 80mm	\leq 4.3 cm ⁻¹ $\sigma_{\rm rms}$ \leq 1.6nm	0.6nm	~	
	Surface Errors Surface 2	Low Spatial Frequency Band Central 200mm	\leq 4.3 cm ⁻¹ $\sigma_{rms} \leq$ 3.2nm	1.2nm	~	
	Surf	High Spatial Frequency Band Central 80 & 200 mm	$\leq 4.3 - 7,500 \text{ cm}^{-1}$ $\sigma_{rms} < 0.2 \text{nm}$	0.15 0.15		

		Specification	Certification	V
& Polish	Scratches	The Total Area of scratches within the central 80mm diameter shall not exceed 25 X 10^3 square micrometers (width x length). < 10,000	Hand Sketch w/dimensions	~
	Scra	The total area of scratches outside the central 80 mm diameter shall not exceed 250 x 10 ³ square micrometers.	Hand Sketch w/dimensions	~
4	st	There shall be no more than 10 point defects within the central 80mm diameter.	Hand Sketch w/dimensions	-
Scratches, Point Defects Side 1	Point Defects	There shall be no more than 100 point defects on the entire surface. Point defects of radius greater than 25 micrometers are treated like scratches for the purpose of this specification. Point defects of radius less than 2.5 micrometers are disregarded.	Hand Sketch w/dimensions	V
Scratches,	Side/Bevel Polish	Sides and bevels shall be polished from a three micrometer grit finish. These surfaces shall appear transparent with no gray, scuffs or scratches visible to the naked eye when viewed in normal room light against a black background.	Inspection Report	

LIGO Component Specification Verification Sheet Input Test Mass

		Specification	Certification	1
lish	Scratches	The total area of scratches shall not exceed 75×10^3 square micrometers over the central 80mm (width x length).	Hand Sketch w/dimensions	~
& Polish	Scra	The total area of scratches outside the central 80 mm diameter shall not exceed 750 x 10 ³ square micrometers.	Hand Sketch w/dimensions	~
ects	ts	There shall be no more than 30 point defects within the central 80mm diameter.	Hand Sketch w/dimensions	~
Scratches, Point Defects Side 2	Point Defects	There shall be no more than 100 point defects on the entire optic. Point defects of radius greater than 25 micrometers are treated like scratches for the purpose of this specification. Point defects of radius less than 2.5 micrometers are disregarded.	Hand Sketch w/dimensions	V
	Side/Bevel Polish	Sides and bevels shall be polished from a three micrometer grit finish. These surfaces shall appear transparent with no gray, scuffs or scratches visible to the naked eye when viewed in normal room light against a black background.	Inspection Report	~

LIGO Component Specification Verification Sheet Input Test Mass



Telecommunications & Industrial Physics

Bradfield Road, West Lindfield PO Box 218 Lindfield NSW 2070 Tel: 9413.7620 Fax:9413.7200

17 February 1999

LIGO Document Control Center C/o Linda Turner LIGO Project, Mail Code 51-33 California Institute of Technology Pasadena CA 91125 USA

Certification data – 4ITM06 (Attention: Garilynn Billingsley)

Please find enclosed a certification package for LIGO Core Optics Component 4ITM06, manufactured by CSIRO under purchase order PC167159. An invoice for this component is also enclosed.

Regards

Chris Walsh

Optics and Surface Science

attachment: Invace 1190.0990245-00-D (processed reparately)

LIGO Certification Report

This Certification Package relates to the following substrate: Input Test Mass (4 km)

Serial number: 4ITM06

The Package consists of the following documents:

1. Printed documents

HABA - LIGO - C - PD: Certification of Physical Dimensions and

Registration Mark location, orientation and

dimensions

HABA - LIGO - C - SB: Certification of Side and Bevel Polish

HABA - LIGO - C - SP: Certification of Scratches and Point Defects

HABA - LIGO - C - SN: Certification of Serial Number location,

dimensions

HABA - LIGO - C - SF: Certification of Surface Figure for Sides 1 and 2

HABA - LIGO - C - SL: Certification of Surface Errors - Low Frequency,

for Sides 1 and 2

HABA - LIGO - C - SH: Certification of Surface Errors - High

Frequency, for Sides 1 and 2

Attachment 1 Hard copy print out of LADI data for Side 1 with

piston, tilt removed and also for piston, tilt,

power, astigmatism removed

Attachment 2 Hard copy print out of LADI data for Side 2 with

piston, tilt, removed and also for piston, tilt,

power, astigmatism removed

Attachment 2A Hard copy print out of LADI data for transmitted

wave front in measurement configuration where beam enters through side 2, reflects from side 1 and exits through side 2, with piston, tilt

removed and also for piston, tilt, power,

astigmatism removed

Attachment 3 Hard copy printouts of TOPO 2D data obtained

with 2.5X and 40X heads at three central

positions (side 1)

Attachment 4 Hard copy printouts of TOPO 2D data obtained

with 2.5X and 40X heads at three central

positions (side 2)

LIGO Certification Report

2. Electronic data

Surface maps for sides 1 and 2 are available at the CSIRO ftp site under the following file names:

LADI data:	4ITM6C1.zip (Side 1)	4ITM6C2.zip (Side 2) 4ITM6C2A.zip (wave front)
TOPO data: (2.5X)	T24IM61A.asc (Side 1)	T24IM62A.asc (Side 2)
	T24IM61B.asc	T24IM62B.asc
	T24IM61C.asc	T24IM62B.asc
(40X)	T44IM61A.asc	T44IM62A.asc
	T44IM61B.asc	T44IM62B.asc
	T44IM61C.asc	T44IM62C.asc

1	Substrate Type:	4ITM
2	Serial Number:	4ITM06
3	Physical quantity certified:	Physical Dimensions and Registration Mark
4	LIGO specification reference:	D960803-B-D
5	CSIRO measurement/inspection procedure reference:	HABA-LIGO-M-PD
6	Variations to the measurement/inspection procedure: (indicate Yes/No and attach separate sheet if Yes)	No
7	CSIRO Log Book Reference	LN00028 P. 30
8	Team member responsible for measurement/inspection:	C Sona
9	Measurement/inspection results reviewed by:	C Walsh

[Measurement errors (\pm 1 σ) shown only where they are comparable to tolerances specified or when measurement is within 2 σ of boundary of acceptability]

	Physical Quantity	Result
Diameter		250.95 mm
Cylindricity		0.01 mm
Thickness	(maximum - for FM, RM, ETM)	100.013 mm
	(minimum - for BS)	(0.013 mm above top tolerance)
Bevel as per drawing (height, angle):		(S1) Height: 2.18 mm Angle:45 ⁰ 18'
		(S2) Height: 2.18 mm Angle:44 ⁰ 19'
Wedge angle	:	1012'
	egistration mark (± angle with respect part thickness):	-7 "
Location of other 3 marks (with respect to registration mark at minimum thickness)		89°59', 180°00', 270°03'
Registration	mark dimensions (OK/ not OK)	OK

11. Certification

The measurements and inspection data presented in this report were obtained using the procedures outlined in the relevant CSIRO procedures document (sec. 5). These results have been reviewed against the LIGO specifications (sec. 4). Taking into account the variations (if any) from these measurement procedures noted in sec.6, CSIRO certifies the substrate to comply with the LIGO specification for this physical quantity. (NB with exception of thickness variation noted in sec.10)

Project Manager:

17 Feb 99

Chris Walsh

Date:

1	Substrate Type:	4ITM
2	Serial Number:	4ITM06
3	Physical quantity certified:	Side and Bevel Polish
4	LIGO specification reference:	E960093-C-D
5	CSIRO measurement/inspection procedure reference:	HABA-LIGO-M-SB-A
6	Variations to the measurement/inspection procedure: (indicate Yes/No and attach separate sheet if Yes)	No
7	CSIRO Log Book Reference	LN00062
8	Team member responsible for measurement/inspection:	E Pavlovic
9	Measurement/inspection results reviewed by:	J Seckold

Defects, if any, in the side and bevel polish compared to the LIGO specification (4 above) are detailed below (team member to note defects here; if none seen, note "no defects observed").

No defects observed

11. Certification

The measurements and inspection data presented in this report were obtained using the procedures outlined in the relevant CSIRO procedures document (sec. 5). These results have been reviewed against the LIGO specifications (sec. 4). Taking into account the variations (if any) from these measurement procedures noted in sec.6, CSIRO certifies the substrate to comply with the LIGO specification for this physical quantity.

Project Manager:

17 Feb 99

Chris Walsh

Date:

Document number: HABA - LIGO - C - SB - A

1	Substrate Type:	4ITM
2	Serial Number:	4ITM06
3	Physical quantity certified:	Serial Number and location
4	LIGO specification reference:	E960093-C-D
5	CSIRO measurement/inspection procedure reference:	HABA-LIGO-M-SN-A
6	Variations to the measurement/inspection procedure: (indicate Yes/No and attach separate sheet if Yes)	No
7	CSIRO Log Book Reference	LN00062
8	Team member responsible for measurement/inspection:	E Pavlovic
9	Measurement/inspection results reviewed by:	J Seckold

Quantity inspected	Result of Inspection (OK / not OK)
Location of serial number as per drawing (sec. 4)	OK
Orientation of serial number as per drawing (sec. 4)	OK
Height of lettering	OK

11. Certification

The measurements and inspection data presented in this report were obtained using the procedures outlined in the relevant CSIRO procedures document (sec. 5). These results have been reviewed against the LIGO specifications (sec. 4). Taking into account the variations (if any) from these measurement procedures noted in sec.6, CSIRO certifies the substrate to comply with the LIGO specification for this physical quantity.

Project Manager:	Mash	Chris Walsh
Date:	17 Feb 99	

Document number: HABA - LIGO - C - SN - A

LIGO Certification Report

Scratches / Defects

1	Substrate Type:	4ITM
2	Serial Number:	4ITM06
3	Physical quantity certified:	Scratches and Point Defects
4	LIGO specification reference:	E960093-C-D
5	CSIRO measurement/inspection procedure reference:	HABA-LIGO-M-SP-A
6	Variations to the measurement/inspection procedure: (indicate Yes/No and attach separate sheet if Yes)	No
7	CSIRO Log Book Reference	LN00062
8	Team member responsible for measurement/inspection:	E Pavlovic
9	Measurement/inspection results reviewed by:	J Seckold

10. Results

	Numbers of point defects		Total Area of scratches (square micrometres)	
	Inside central 80 mm	Entire surface (235 mm)	Inside central 80 mm	Outside central 80 mm (235 mm)
Surface 1	Nil	Nil	< 10,000	< 45,000
Surface 2	Nil	Nil	Nil	< 5,000

11. Certification

The measurements and inspection data presented in this report were obtained using the procedures outlined in the relevant CSIRO procedures document (sec. 5). These results have been reviewed against the LIGO specifications (sec. 4). Taking into account the variations (if any) from these measurement procedures noted in sec.6, CSIRO certifies the substrate to comply with the LIGO specification for this physical quantity.

Project Manager:	Ellash	Chris Walsh
Date:	17 Feb 99	

Document number: HABA - LIGO - C - SP - A





51DE2

1	Substrate Type:	4ITM
2	Serial Number:	4ITM06
3	Physical quantity certified:	Surface Figure
4	LIGO specification reference:	E960093-C-D
5	CSIRO measurement/inspection procedure reference:	HABA-LIGO-M-SF-A
6	Variations to the measurement/inspection procedure: (indicate Yes/No and attach separate sheet if Yes)	No. Data files for transmitted wavefront represent two passes
7	CSIRO Log Book Reference	LLN/0137-02, Book 5, p. 71
8	Team member responsible for measurement/inspection:	E Pavlovic
9	Measurement/inspection results reviewed by:	B Oreb

	Radius of Curvature in km	Astigmatism (nm)	Electronic data file reference
Surface 1	13.63	6.2	4ITM6C1.zip
Surface 2	11.60	4.1	4ITM6C2.zip
Wavefront*	-5.03		4ITM6CT.zip

Measured as per the test procedure in E960093-C-D.

Hardcopies of the phase maps are attached to this certification as part of Attachment 1 for Side 1 and Attachment 2 for Side 2. Phase map data is stored in electronic format at the CSIRO ftp site under the filenames shown in the third column.

11. Certification

The measurements and inspection data presented in this report were obtained using the procedures outlined in the relevant CSIRO procedures document (sec. 5). These results have been reviewed against the LIGO specifications (sec. 4). Taking into account the variations (if any) from these measurement procedures noted in sec.6, CSIRO certifies the substrate to comply with the LIGO specification for this physical quantity.

Project Manager:	Clash	Chris Wals
Date:	17 Feb 99	

Document number: HABA - LIGO - C - SF - A

1	Substrate Type:	4ITM
2	Serial Number:	4ITM06
3	Physical quantity certified:	Surface Errors - Low Spatial Frequency
4	LIGO specification reference:	E960093-C-D
5	CSIRO measurement/inspection procedure reference:	HABA-LIGO-M-SL-A
6	Variations to the measurement/inspection procedure: (indicate Yes/No and attach separate sheet if Yes)	No
7	CSIRO Log Book Reference	LLN/0137-02, Book 5, p.71
8	Team member responsible for measurement/inspection:	E Pavlovic
9	Measurement/inspection results reviewed by:	B Oreb

	Low Frequency Surface Errors (nm)				
	80 mm aperture	200 mm aperture			
Surface 1	0.6	1.3			
Surface 2	0.6	1.2			

Hardcopies of the phase maps over the central 200 mm with piston, tilt, power and astigmatism removed are attached to this certification in Attachment 2 for Side 1 and Attachment 2 for Side 2.

11. Certification

The measurements and inspection data presented in this report were obtained using the procedures outlined in the relevant CSIRO procedures document (sec. 5). These results have been reviewed against the LIGO specifications (sec. 4). Taking into account the variations (if any) from these measurement procedures noted in sec.6, CSIRO certifies the substrate to comply with the LIGO specification for this physical quantity.

Project Manager:

Chris Walsh

Date:

Document number: HABA - LIGO - C - SL - A

1	Substrate Type:	4ITM
2	Serial Number:	4ITM06
3	Physical quantity certified:	Surface Errors - high spatial frequency
4	LIGO specification reference:	E960093-C-D
5	CSIRO measurement/inspection procedure reference:	HABA-LIGO-M-SH-A
6	Variations to the measurement/inspection procedure: (indicate Yes/No and attach separate sheet if Yes)	No
7	CSIRO Log Book Reference	LLN/091
8	Team member responsible for measurement/inspection:	F Lesha
9	Measurement/inspection results reviewed by:	C Walsh

10.1 Surface errors in nanometres averaged over sampling locations within central 80 mm:

Side 1:

0.19

Side 2:

0.15

10.2 Surface errors in nanometres averaged over all sampling locations on surface:

Side 1:

0.20

Side 2:

0.15

10.3 Surface errors in nanometres at different positions A through H on surface:

	A	В	C	D	E	F	G	H
Surface 1	0.19	0.20	0.19	0.18	0.18	0.20	0.21	0.21
Surface 2	0.14	0.14	0.16	0.17	0.14	0.16	0.17	0.16

Two - dimensional surface maps at three central locations are available at the CSIRO ftp site under filenames of the form TMXX0YZA.asc, where M is the objective used (M=2 for 2.5X, 4 for 40X), XX is the substrate type, 0Y is the number, Z=1 or 2 is the side and A=A, B, C, ... is the sampling position. Hard copies of the data are at Attachment 3 (Side 1) and Attachment 4 (Side 2).

11. Certification

The measurements and inspection data presented in this report were obtained using the procedures outlined in the relevant CSIRO procedures document (sec. 5). These results have been reviewed against the LIGO specifications (sec. 4). Taking into account the variations (if any) from these measurement procedures noted in sec.6, CSIRO certifies the substrate to comply with the LIGO specification for this physical quantity.

[[[a]]] 17 Feb 99 Project Manager: Chris Walsh

Date:

LADI CERTIFICATION DATA

Title: 4ITM061

Date: 11/10/98

Diameter: 200 mm

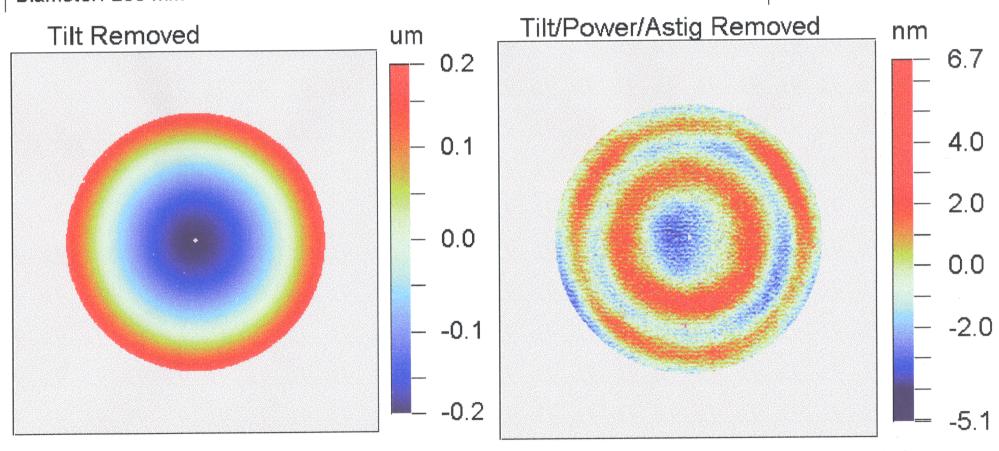
Astig: 6.2 nm

Power: 367.7 nm



PV: 11.8 nm

RMS: 1.3 nm



AHCh

LADI CERTIFICATION DATA

Title: 4ITM062

Date: 12/17/98

Diameter: 200 mm

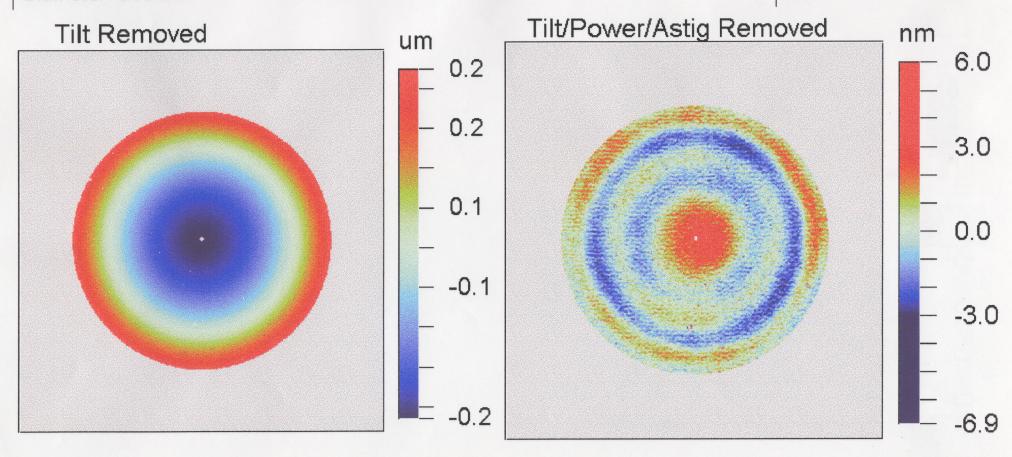
Astig: 4.1 nm

Power: 431.9 nm



PV: 12.9 nm

RMS: 1.2 nm



LADI CERTIFICATION DATA

Title: 4ITM06T

Date: 02/08/99

Diameter: 200 mm

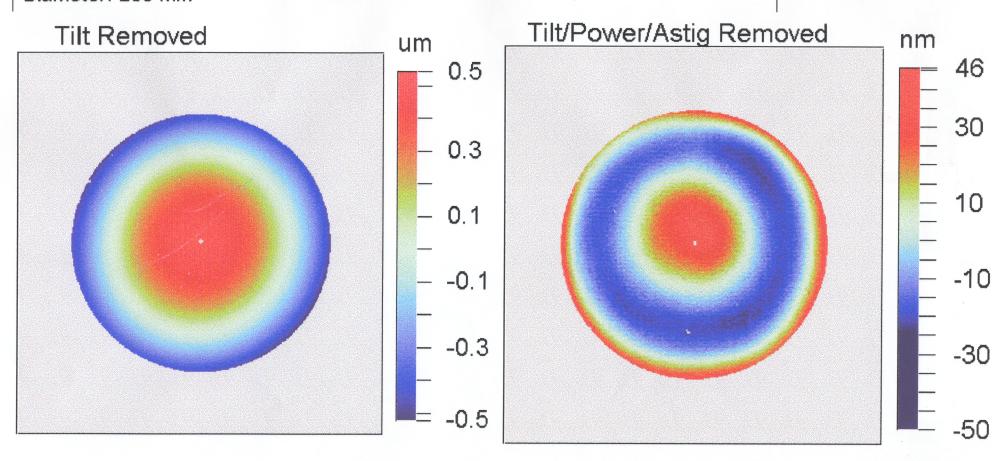
Astig: -79.0 nm

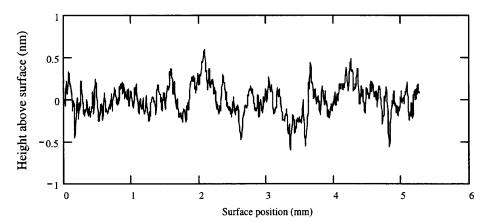
Power: -995.1 nm



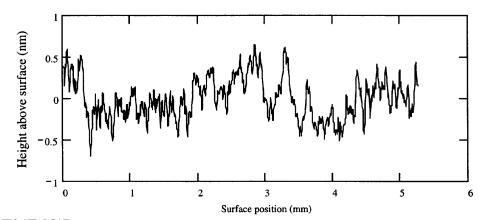
PV: 95.5 nm

RMS: 16.1 nm

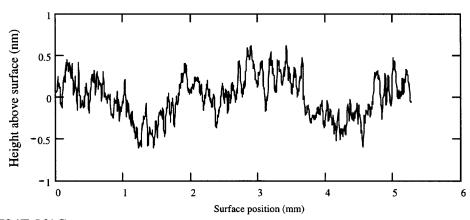




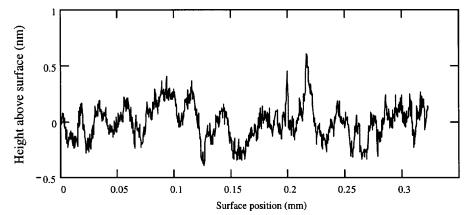
T24IM61A.asc



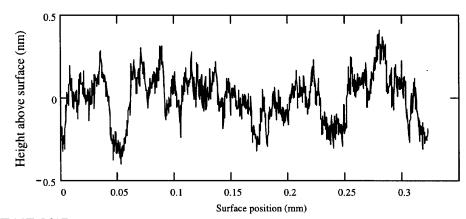
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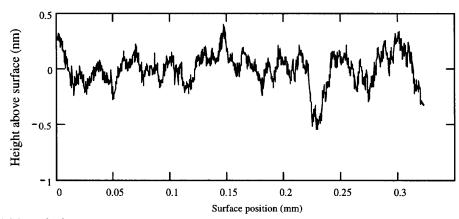
T24IM61C.asc



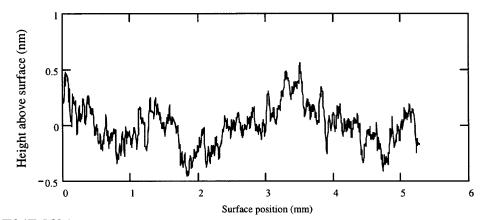
T44IM61A.asc



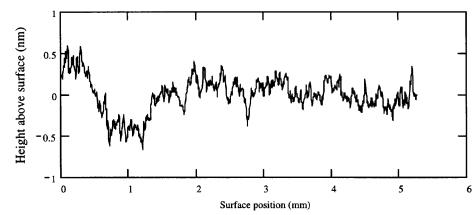
T44IM61B.asc



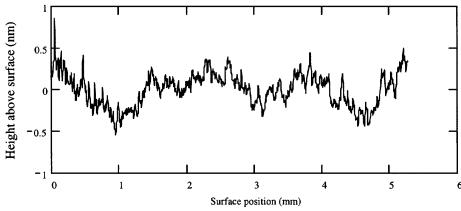
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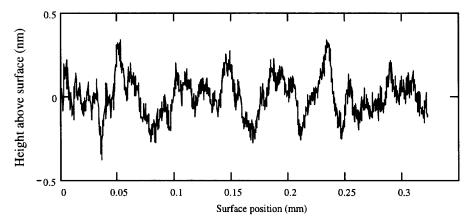
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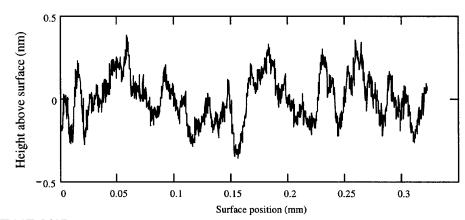
T24IM62B.asc



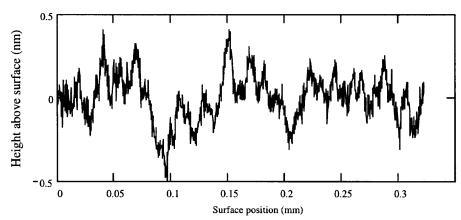
T24IM62C.asc



T44IM62A.asc



T44IM62B.asc



T44IM62C.asc





Classic 164 Currency Converter

Friday, February 19, 1999

30,404 US Dollar = 47,857.7 Australian Dollar

30,404 Australian Dollar (AUD) = 19,315.7 US Dollar (USD)

Median price was 1.5726 / 1.5741 (bid/ask).

Minimum price was 1.5662 / 1.5674

Maximum price was 1.5785 / 1.5798

75% of the prices were above 1.5686 / 1.5700 and below 1.5753 / 1.5768

Computed from a sample of 665 prices on Thursday, February 18, 1999

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Understanding the results	
Personalize	with amount:
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- Margined forex trading accounts available through <u>Linnco Europe</u>